## **ESD Protection Diode** Single Line CAN/LIN Bus Protector

This integrated surge protection device (surge protection) is designed for applications requiring transient overvoltage protection. It is intended for use in sensitive equipment such as computers, printers, business machines, communication systems, medical equipment, and other applications. Its integrated design provides very effective and reliable protection for four separate lines using only one package. These devices are ideal for situations where board space is at a premium. **Features** 

- Low Clamping Voltage
- Small SC-88A SMT Package
- Stand Off Voltage: 5 V
- Low Leakage Current <  $1 \mu A$
- Four Separate Unidirectional Configurations for Protection
- ESD Protection: IEC61000-4-2: Level 4

MILSTD 883C - Method 3015-6: Class 3

• Pb-Free Packages are Available

## Benefits

- Provides Protection for ESD Industry Standards: IEC 61000, HBM
- Minimize Power Consumption of the System
- Minimize PCB Board Space

## **Typical Applications**

- Instrumentation Equipment
- Serial and Parallel Ports
- Microprocessor Based Equipment
- Notebooks, Desktops, Servers
- Cellular and Portable Equipment

### MAXIMUM RATINGS (T<sub>A</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Power Dissipation 8 × 20 μsec Double Exponential Waveform (Note 1)	P <sub>PK</sub>	20	W
Steady State Power – 1 Diode (Note 2)	PD	380	mW
Thermal Resistance – Junction–to–Ambient Above 25°C, Derate	$R_{ heta JA}$	327 3.05	°C/W mW/°C
Operating Junction Temperature Range	TJ	-40 to +125	°C
Storage Temperature Range	T <sub>stg</sub>	-55 to +150	°C
Lead Solder Temperature – Maximum 10 Seconds Duration	ΤL	260	°C
IEC ^1000-4-2 (ESD) Contact		±8.0	kV

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

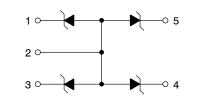
1. Non-repetitive current pulse per Figure 6.

 Only 1 diode under power. For all 4 diodes under power, P<sub>D</sub> will be 25%. Mounted on FR4 board with min pad.



## **ON Semiconductor®**

## www.onsemi.com





SC-88A/SOT-353 CASE 419A-02

### MARKING DIAGRAM



- x = H for NSQA6V8AW5T2
  - X for NSQA12VAW5T2
  - = Date Code

Μ

= Pb-Free Package

(Note: Microdot may be in either location)

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NSQA6V8AW5T2	SC-88A	3000/Tape & Reel
NSQA6V8AW5T2G	SC-88A (Pb-Free)	3000/Tape & Reel
NSQA12VAW5T2	SC-88A	3000/Tape & Reel
NSQA12VAW5T2G	SC-88A (Pb-Free)	3000/Tape & Reel

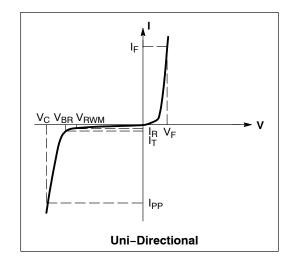
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

See Application Note AND8308/D for further description of survivability specs.

## **ELECTRICAL CHARACTERISTICS**

 $(T_{\Delta} = 25^{\circ}C \text{ unless otherwise noted})$ 

Symbol	Parameter		
I <sub>PP</sub>	Maximum Reverse Peak Pulse Current		
V <sub>C</sub>	Clamping Voltage @ IPP		
V <sub>RWM</sub>	Working Peak Reverse Voltage		
I <sub>R</sub>	Maximum Reverse Leakage Current @ V <sub>RWM</sub>		
V <sub>BR</sub>	Breakdown Voltage @ I <sub>T</sub>		
Ι <sub>Τ</sub>	Test Current		
١ <sub>F</sub>	Forward Current		
V <sub>F</sub>	Forward Voltage @ I <sub>F</sub>		
P <sub>pk</sub>	Peak Power Dissipation		
С	Capacitance @ $V_R = 0$ and f = 1.0 MHz		



\*See Application Note AND8308/D for detailed explanations of datasheet parameters.

## **ELECTRICAL CHARACTERISTICS** (T<sub>A</sub> = $25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
NSQA6V8AW5T2				•	•
Breakdown Voltage (I <sub>T</sub> = 1 mA) (Note 3)	V <sub>BR</sub>	6.4	6.8	7.1	V
Leakage Current (V <sub>RWM</sub> = 5.0 V)	I <sub>R</sub>	-	-	1.0	μA
Clamping Voltage 1 (I <sub>PP</sub> = 1.6 A) (Note 4)	V <sub>C</sub>	-	-	13	V
Maximum Peak Pulse Current (Note 4)	I <sub>PP</sub>	-	-	1.6	Α
Junction Capacitance – (V <sub>R</sub> = 0 V, f = 1 MHz) – (V <sub>R</sub> = 3.0 V, f = 1 MHz)	CJ		12 6.7	15 9.5	pF
Clamping Voltage - Per IEC61000-4-2	V <sub>C</sub>	Figures 1 and 2			V
NSQA12VAW5T2					
Breakdown Voltage (I <sub>T</sub> = 5 mA) (Note 3)	V <sub>BR</sub>	11.4	12.0	12.7	V
Leakage Current (V <sub>RWM</sub> = 9.0 V)	I <sub>R</sub>	-	-	0.05	μA
Zener Impedence (I <sub>T</sub> = 5 mA)	ZZ	-	-	30	Ω
Clamping Voltage 1 (I <sub>PP</sub> = 0.9 A) (Note 4)	V <sub>C</sub>	-	-	23	V
Maximum Peak Pulse Current (Note 4)	I <sub>PP</sub>	-	-	0.9	Α
Junction Capacitance - (V <sub>R</sub> = 0 V, f = 1 MHz)	CJ	_	-	15	pF
Clamping Voltage - Per IEC61000-4-2 (Note 5)	V <sub>C</sub>	Figures 1 and 2		V	

V<sub>BR</sub> is measured at pulse test current I<sub>T</sub>.
Surge current waveform per Figure 5.
For test procedure see Figures 3 and 4 and Application Note AND8307/D.

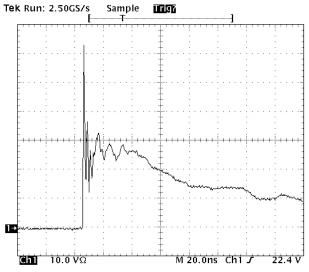
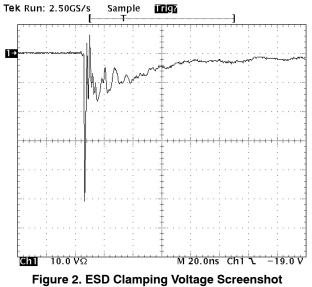


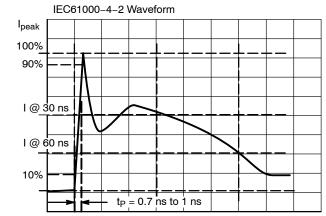
Figure 1. ESD Clamping Voltage Screenshot Positive 8 kV Contact per IEC61000-4-2

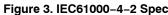


Negative 8 kV Contact per IEC61000–4–2

#### IEC 61000-4-2 Spec.

Level	Test Volt- age (kV)	First Peak Current (A)	Current at 30 ns (A)	Current at 60 ns (A)
1	2	7.5	4	2
2	4	15	8	4
3	6	22.5	12	6
4	8	30	16	8





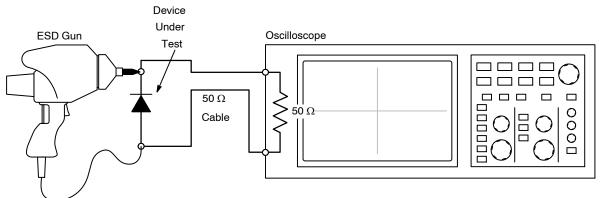


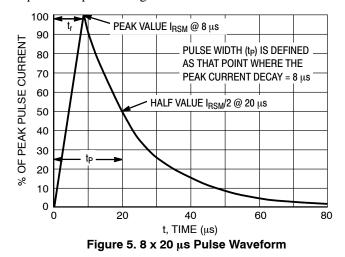
Figure 4. Diagram of ESD Test Setup

## The following is taken from Application Note AND8308/D – Interpretation of Datasheet Parameters for ESD Devices.

## **ESD Voltage Clamping**

For sensitive circuit elements it is important to limit the voltage that an IC will be exposed to during an ESD event to as low a voltage as possible. The ESD clamping voltage is the voltage drop across the ESD protection diode during an ESD event per the IEC61000–4–2 waveform. Since the IEC61000–4–2 was written as a pass/fail spec for larger

systems such as cell phones or laptop computers it is not clearly defined in the spec how to specify a clamping voltage at the device level. ON Semiconductor has developed a way to examine the entire voltage waveform across the ESD protection diode over the time domain of an ESD pulse in the form of an oscilloscope screenshot, which can be found on the datasheets for all ESD protection diodes. For more information on how ON Semiconductor creates these screenshots and how to interpret them please refer to AND8307/D.



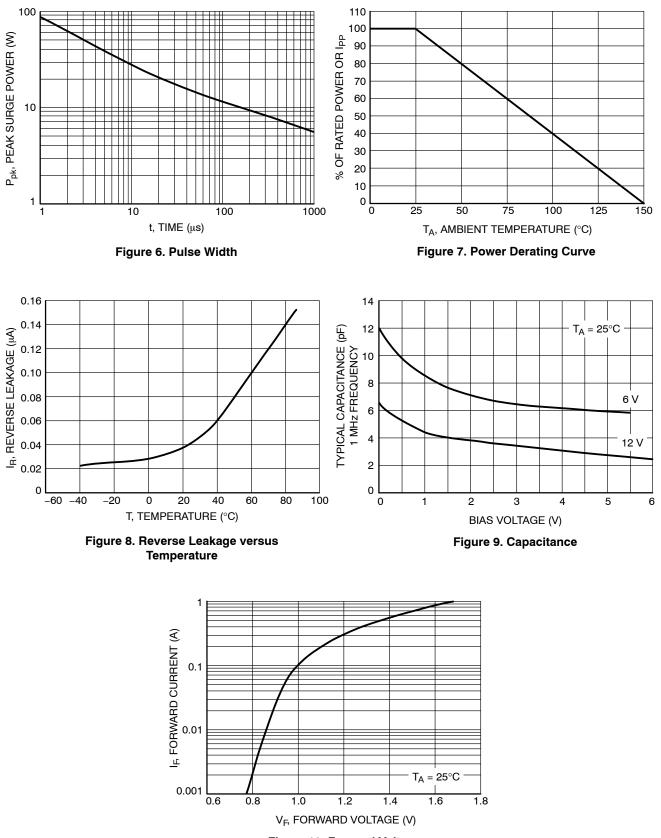
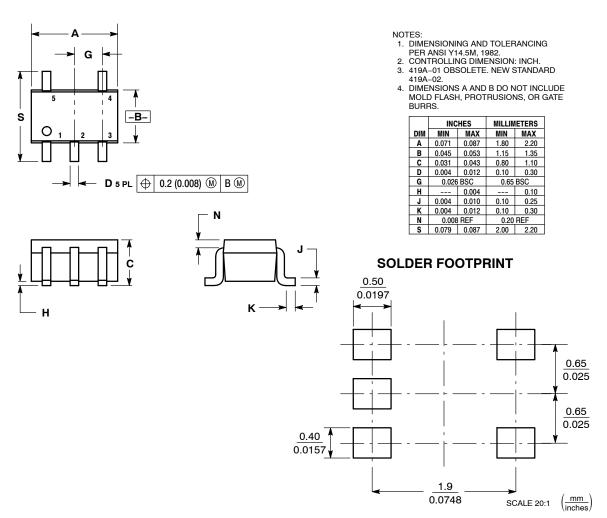


Figure 10. Forward Voltage

## PACKAGE DIMENSIONS

SC-88A (SC-70-5/SOT-353) CASE 419A-02 ISSUE L



ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor roducts, 'Typical' parameters which may be provided in ON Semiconductor dates sheets and/or regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor hard usuthorized applications harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application. Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affili

#### PUBLICATION ORDERING INFORMATION

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative